

**Initial Release** 

# N- and P-Channel Enhancement-Mode MOSFET Pair

#### **Features**

- □ Integrated gate-source resistor
  □ Integrated gate-source zener diode
  □ Low threshold
  □ Low on-resistance
  □ Independent N- and P-channels
- Electrically isolated N- and P-channels
- □ Low input capacitance□ Fast switching speeds
- ☐ Free from secondary breakdowns
- Low input and output leakage

## **Application**

| Ц | High voltage pulsers |
|---|----------------------|
|   | Amplifiers           |

☐ Buffers

□ Piezoelectric transducer drivers

☐ General purpose line drivers

■ Logic level interfaces

## Absolute Maximum Ratings\*

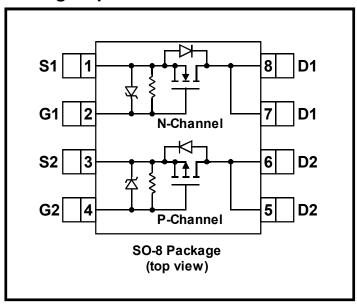
| Drain-to-Source Voltage           | BV <sub>DSS</sub> |
|-----------------------------------|-------------------|
| Drain-to-Gate Voltage             | $BV_{DGS}$        |
| Operating and Storage Temperature | -55°C to +150°C   |
| Soldering Temperature*            | 300°C             |

<sup>\*</sup>Distance of 1.6mm from case for 10 seconds.

#### **General Description**

The Supertex TC6320TG consists of a high voltage low threshold N-channel and P-channel MOSFET in an SO-8 package. Both MOSFETs have integrated gate-source resistors and gate-source zener diode clamps which are desired for high voltage pulser applications. TC6320TG, a complementary high-speed, high voltage, gate-clamped N- and P-channel MOSFET pair in a single SO-8 package. The TC6320TG offers 200V breakdown voltage, 2.0A output peak current and low input capacitance. The 2.0A output current capability will minimize rise and fall times. The low input capacitance will minimize propagation delay times and also rise and fall times. The MOSFETs have integrated gate-source resistors and gate-source zener diode clamps that are desired for high voltage pulser applications saving board space and improving performance. It is specifically designed for applications in medical ultrasound transmitters and nondestructive evaluation in materials flaw detection, but it can also be used as an efficient buffer.

### **Package Option**





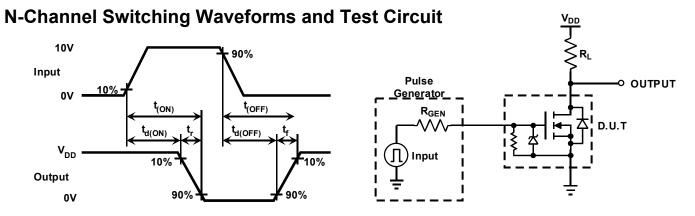
| BV <sub>DSS</sub> | BV <sub>DGS</sub> | R <sub>DS(ON</sub> | (max)     | Order Number / Package |  |  |
|-------------------|-------------------|--------------------|-----------|------------------------|--|--|
| N-Channel         | P-Channel         | N-Channel          | P-Channel | SO-8                   |  |  |
| 200V              | -200V             | 7.0Ω               | 8.0Ω      | TC6320TG               |  |  |

#### N-Channel Electrical Characteristics (at T<sub>A</sub>=25°C unless otherwise specified)

| Symbol              | Parameter                                      | Min  | Тур | Max  | Units | Conditions                                       |
|---------------------|--|------|-----|------|-------|--|
| BV <sub>DSS</sub>   | Drain-to-Source                                | 200  |     |      | V     | $V_{GS}$ =0V, $I_D$ =2mA                         |
|                     | Breakdown Voltage                              |      |     |      |       |  |
| $V_{GS(th)}$        | Gate Threshold Voltage                         | 1.0  |     | 2.0  | V     | $V_{GS}=V_{DS}$ , $I_{D}=1mA$                    |
| $\Delta V_{GS(th)}$ | Change in V <sub>GS(th)</sub> with Temperature |      |     | -4.5 | mV/°C | $V_{GS}=V_{DS}$ , $I_{D}=1mA$                    |
| $R_{GS}$            | Gate-Source Shunt Resistor                     | 10   |     | 50   | KΩ    | I <sub>GS</sub> =100μA                           |
| $\Delta R_{GS}$     | Change in R <sub>GS</sub> with Temperature     |      |     | TBD  | %/°C  | I <sub>GS</sub> =100μA                           |
| $Vz_{GS}$           | Gate-Source Zener Voltage                      | 13.2 |     | 25   | V     | I <sub>GS</sub> =2mA                             |
| $\Delta Vz_{GS}$    | Change in Vz <sub>GS</sub> with Temperature    |      |     | TBD  | mV/°C | I <sub>GS</sub> =2mA                             |
| I <sub>DSS</sub>    | Zero Gate Voltage Drain Current                |      |     | 10   | μA    | V <sub>GS</sub> =0V, V <sub>DS</sub> =Max Rating |
|                     |  |      |     | 1.0  | mA    | $V_{GS}$ =0V, $V_{DS}$ =0.8 Max                  |
|                     |  |      |     |      |       | Rating, T <sub>A</sub> =125°C                    |
| $I_{D(ON)}$         | On-State Drain Current                         | 1.0  |     |      | Α     | $V_{GS}$ =4.5V, $V_{DS}$ =25V                    |
|                     |  | 2.0  |     |      |       | $V_{GS}$ =10V, $V_{DS}$ =25V                     |
| $R_{DS(ON)}$        | Static Drain-to-Source                         |      |     | 8.0  | Ω     | $V_{GS}$ =4.5V, $I_D$ =150mA                     |
|                     | ON-State Resistance                            |      |     | 7.0  |       | $V_{GS}$ =10V, $I_D$ =1.0A                       |
| $\Delta R_{DS(ON)}$ | Change in R <sub>DS(ON)</sub> with Temperature |      |     | 1.0  | %/°C  | $V_{GS}$ =4.5V, $I_D$ =150mA                     |
| $G_{FS}$            | Forward Transconductance                       | 400  |     |      | mmho  | $V_{DS}$ =25V, $I_{D}$ =200mA                    |
| $C_{ISS}$           | Input Capacitance                              |      |     | 110  |       | $V_{GS}$ =0V, $V_{DS}$ =25V                      |
| $C_{OSS}$           | Common Source Output Capacitance               |      |     | 60   | pF    | f=1MHz   |
| $C_{RSS}$           | Reverse Transfer Capacitance                   |      |     | 23   |       |  |
| $t_{d(ON)}$         | Turn-ON Delay Time                             |      |     | 10   |       | V <sub>DD</sub> =25V,                            |
| t <sub>r</sub>      | Rise Time                                      |      |     | 15   | ns    | I <sub>D</sub> =1.0A                             |
| t <sub>d(OFF)</sub> | Turn-Off Delay Time                            |      |     | 20   |       | $R_{GEN}$ =25 $\Omega$                           |
| t <sub>f</sub>      | Fall Time                                      |      |     | 15   |       |  |
| $V_{SD}$            | Diode Forward Voltage Drop                     |      |     | 1.8  | V     | $V_{GS}$ =0V, $I_{SD}$ =0.5A                     |
| t <sub>rr</sub>     | Reverse Recovery Time                          |      | 300 |      | ns    | $V_{GS}$ =0V, $I_{SD}$ =0.5A                     |

Notes:

<sup>2)</sup> All AC parameters sample tested.



<sup>1)</sup> All DC parameters 100% tested at 25°C unless otherwise stated. (Pulsed test: 300µs pulse at 2% duty cycle.)

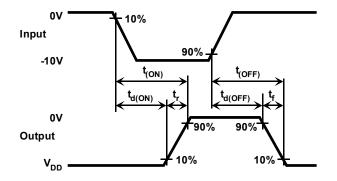
# Supertex inc.

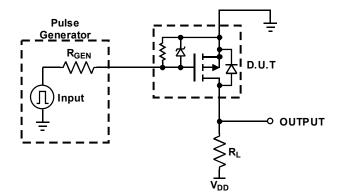
**P-Channel Electrical Characteristics** (at T<sub>A</sub>=25°C unless otherwise specified)

| Symbol              | Parameter                                      | Min  | Тур | Max  | Units | Conditions                                       |
|---------------------|--|------|-----|------|-------|--|
| BV <sub>DSS</sub>   | Drain-to-Source                                | -200 |     |      | V     | $V_{GS}$ =0V, $I_D$ =-2mA                        |
|                     | Breakdown Voltage                              |      |     |      |       |  |
| $V_{GS(th)}$        | Gate Threshold Voltage                         | -1.0 |     | -2.4 | V     | $V_{GS}=V_{DS}$ , $I_{D}=-1mA$                   |
| $\Delta V_{GS(th)}$ | Change in V <sub>GS(th)</sub> with Temperature |      |     | 4.5  | mV/°C | $V_{GS}=V_{DS}$ , $I_{D}=-1mA$                   |
| R <sub>GS</sub>     | Gate-Source Shunt Resistor                     | 10   |     | 50   | KΩ    | I <sub>GS</sub> =-100μA                          |
| $\Delta R_GS$       | Change in R <sub>GS</sub> with Temperature     |      |     | TBD  | %/°C  | I <sub>GS</sub> =-100μA                          |
| Vz <sub>GS</sub>    | Gate-Source Zener Voltage                      | 13.2 |     | 25   | V     | I <sub>GS</sub> =-2mA                            |
| $\Delta V_{GS(th)}$ | Change in Vz <sub>GS</sub> with Temperature    |      |     | TBD  | mV/°C | I <sub>GS</sub> =-2mA                            |
| I <sub>DSS</sub>    | Zero Gate Voltage Drain Current                |      |     | -10  | μΑ    | V <sub>GS</sub> =0V, V <sub>DS</sub> =Max Rating |
|                     |  |      |     | -1.0 | mA    | $V_{GS}$ =0V, $V_{DS}$ =0.8 Max                  |
|                     |  |      |     |      |       | Rating, T <sub>A</sub> =125°C                    |
| $I_{D(ON)}$         | On-State Drain Current                         | -1.0 |     |      | Α     | $V_{GS}$ =-4.5V, $V_{DS}$ =-25V                  |
|                     |  | -2.0 |     |      |       | $V_{GS}$ =-10V, $V_{DS}$ =-25V                   |
| R <sub>DS(ON)</sub> | Static Drain-to-Source                         |      |     | 10   | Ω     | $V_{GS}$ =-4.5V, $I_{D}$ =-150mA                 |
|                     | ON-State Resistance                            |      |     | 8.0  |       | $V_{GS}$ =-10V, $I_{D}$ =-1.0A                   |
| $\Delta R_{DS(ON)}$ | Change in R <sub>DS(ON)</sub> with Temperature |      |     | 1.0  | %/°C  | $V_{GS}$ =-10V, $I_D$ =-200mA                    |
| $G_{FS}$            | Forward Transconductance                       | 400  |     |      | mmho  | $V_{DS}$ =-25V, $I_{D}$ =-200mA                  |
| C <sub>ISS</sub>    | Input Capacitance                              |      |     | 200  |       | $V_{GS}$ =0V, $V_{DS}$ =-25V                     |
| Coss                | Common Source Output Capacitance               |      |     | 55   | pF    | f=1MHz   |
| $C_{RSS}$           | Reverse Transfer Capacitance                   |      |     | 30   |       |  |
| t <sub>d(ON)</sub>  | Turn-ON Delay Time                             |      |     | 10   |       | V <sub>DD</sub> =-25V,                           |
| t <sub>r</sub>      | Rise Time                                      |      |     | 15   | ns    | I <sub>D</sub> =-1.0A                            |
| t <sub>d(OFF)</sub> | Turn-Off Delay Time                            |      |     | 20   |       | $R_{GEN}$ =25 $\Omega$                           |
| t <sub>f</sub>      | Fall Time                                      |      |     | 15   |       |  |
| $V_{SD}$            | Diode Forward Voltage Drop                     |      |     | -1.8 | V     | $V_{GS}$ =0V, $I_{SD}$ =-0.5A                    |
| t <sub>rr</sub>     | Reverse Recovery Time                          |      | 300 |      | ns    | $V_{GS}$ =0V, $I_{SD}$ =-0.5A                    |

#### Notes:

# P-Channel Switching Waveforms and Test Circuit





1/22/03

<sup>1)</sup> All DC parameters 100% tested at 25°C unless otherwise stated. (Pulsed test: 300µs pulse at 2% duty cycle.)

<sup>2)</sup> All AC parameters sample tested.